

A SIM gauge:

Mission

Space Interferometry

Must:

- Measure distance between two fiducials.
- Relative accuracy ~ 10 pm.
- Minimal sensitivity to metrology head mis-orientation. 3.
- Minimal sensitivity to electronic drift. (Favor use of heterodyne technique. 4.
- Be consistent with ~20 other gauges. (Requires use of single laser wavelength standard.)
- Basic components include:
 - Laser, stabilized, $\lambda=1.3$ micron (to not contaminate starlight in the visible) 1.
 - Frequency shifters to enable heterodyne detection 2.
 - Fiber optics for laser light distribution to ~20 metrology heads 3.
 - Metrology heads (includes photodiodes which produce heterodyne interference signals) 4.
 - Fiducial retro-reflectors (corner cubes). 5.
 - Electronics to measure phase of metrology heads' heterodyne outputs. 6.

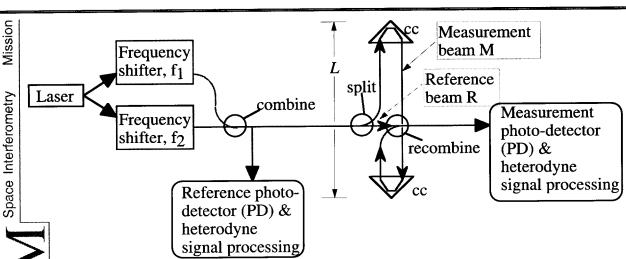
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A generic gauge





• Photodetectors detect heterodyne interference signal, f₂-f₁ (~100 kHz)

- Relative phase of Reference vs. Measurement photodiode signals tells us the Optical Path Difference (OPD) of the M beam vs. the R beam: basis for gauge readout. L=OPD/2.
- For λ =1.3 microns, we need to measure phase difference to 1.5x10⁻⁵ cycles.

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• Incomplete split of M and R beams causes cyclic error.

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Space Interferometry

Space Inter

How precision engineering will help find planets like Earth.

A presentation to the students of Nagaoka University

July 17, 2002

Peter Halverson

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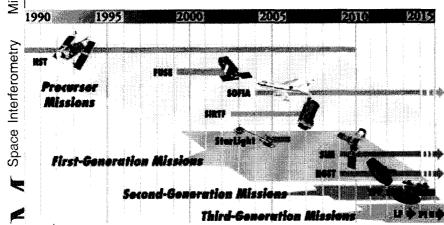


Planet finding missions: NASA timeline



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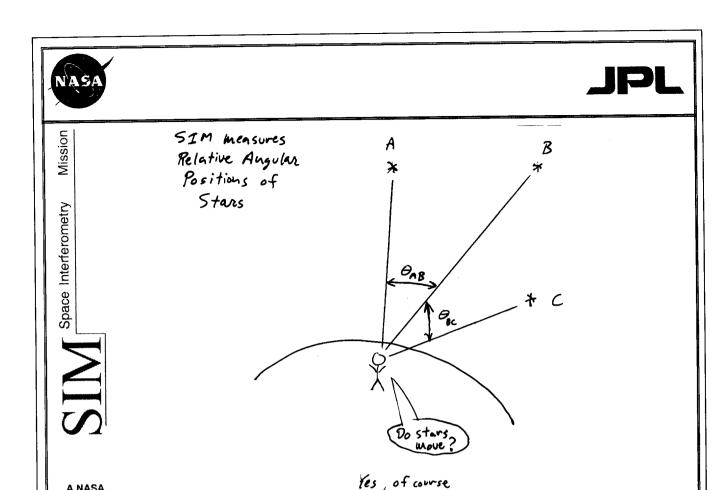
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- •Far Ultraviolet Spectroscopic Explorer
- •Stratospheric Observatory for Infrared Astronomy
- •Space Infrared Telescope Facility
- Starlight
- •Space Interferometry Mission
- •Next Generation Space Telescope
- •Terrestrial Planet Finder
- •Life Finder, Planet Imager

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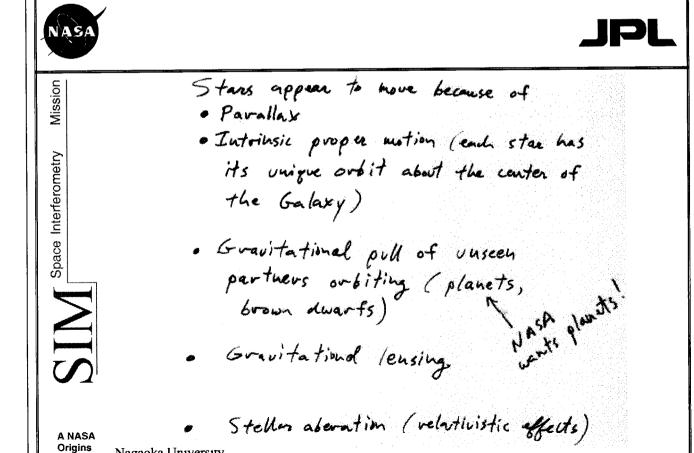
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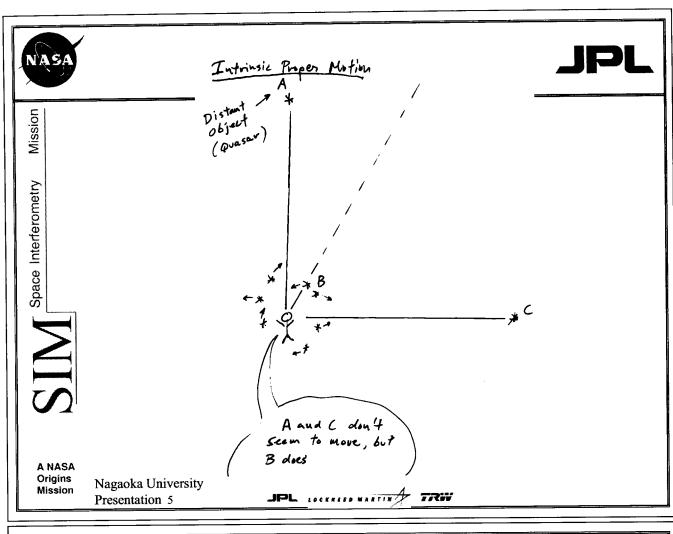
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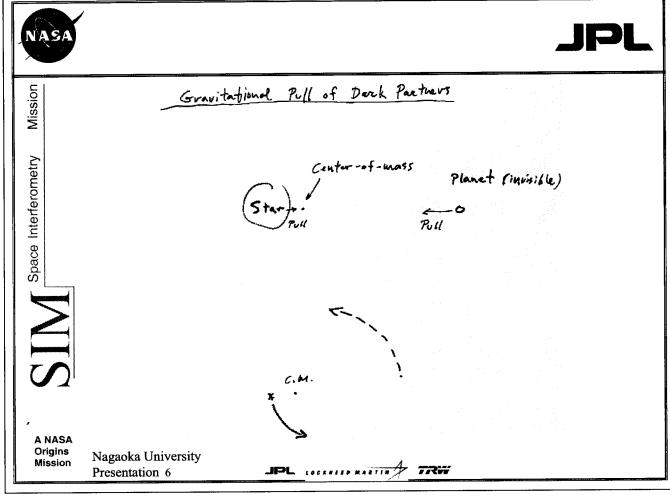
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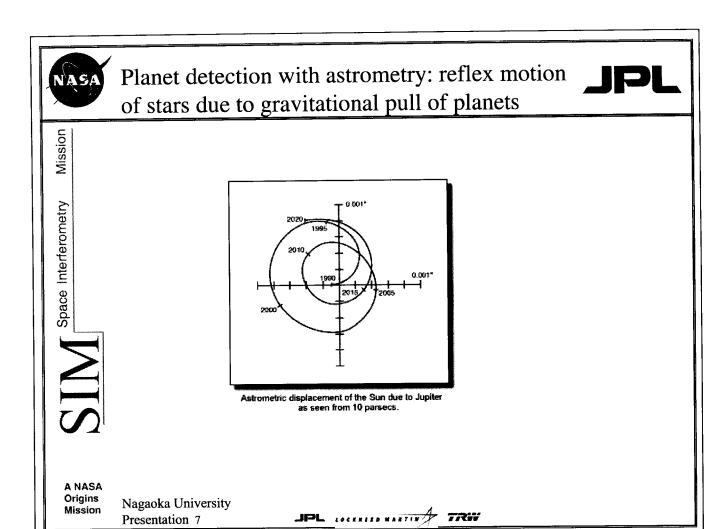
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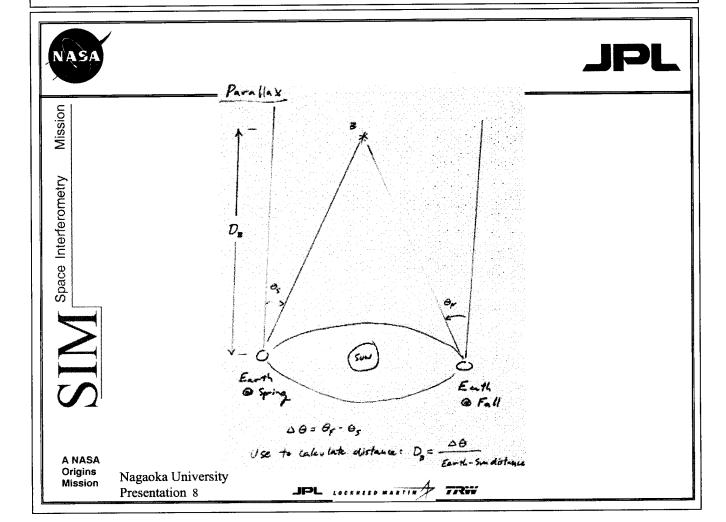
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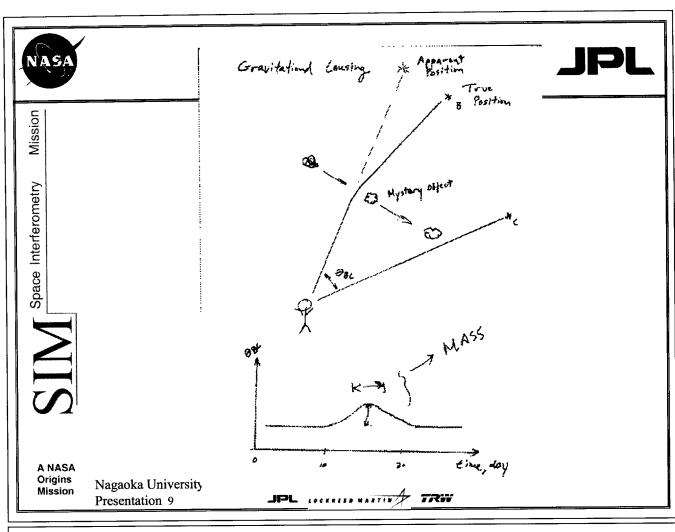


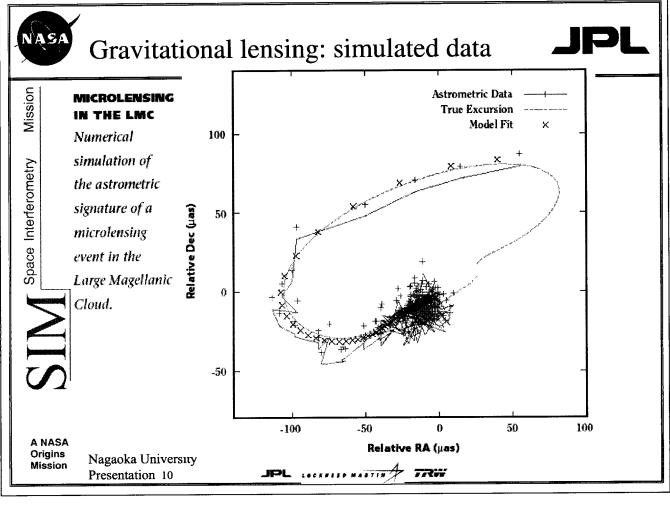


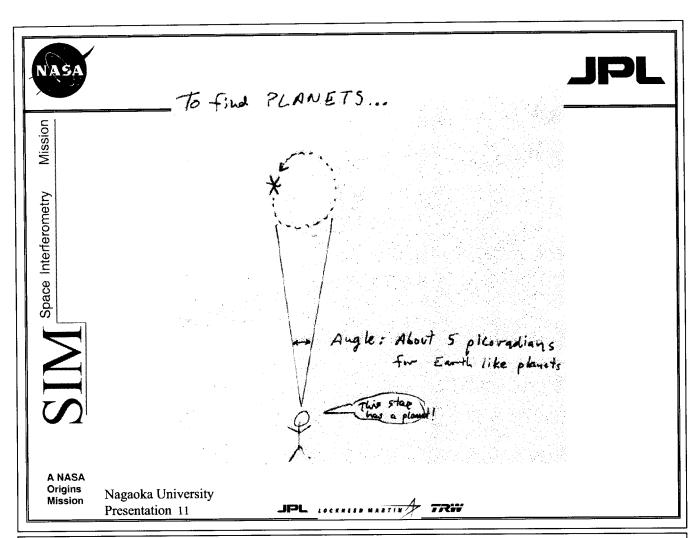


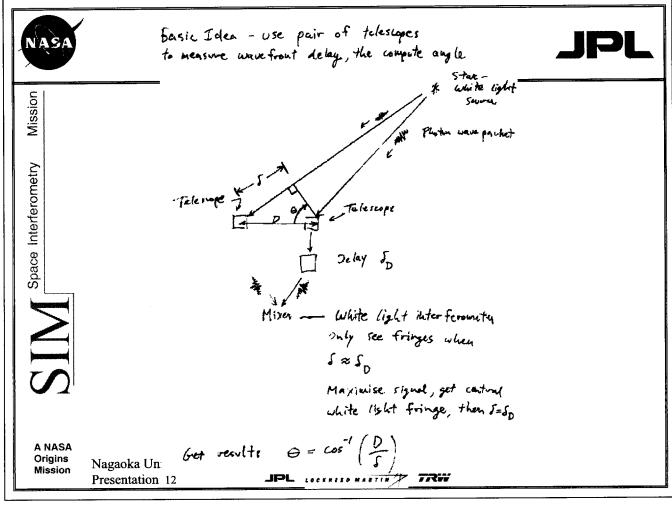


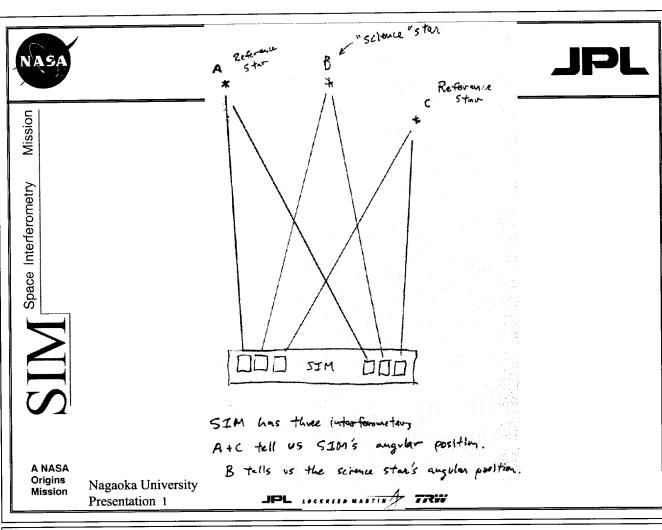


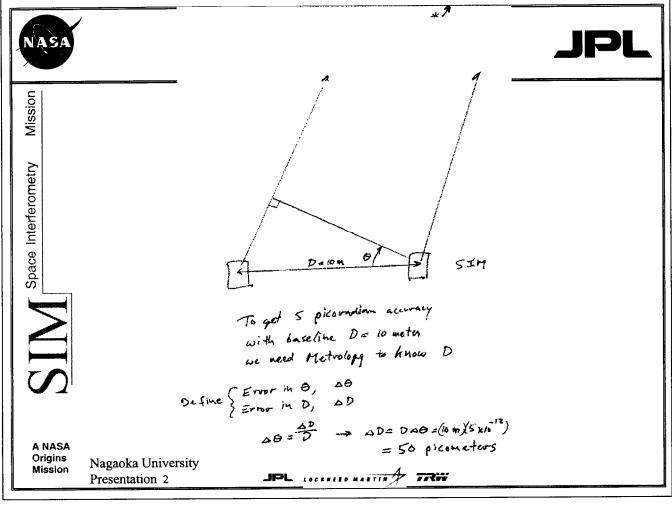














SIM project description

Space Interferometry

Launch in 2008:

- Pico-radian accuracy space "theodolite".
- Compares rapidly changing angular positions of local stars to unchanging distant "reference" objects (such as active galactic nuclei).
- Parallax angles as SIM orbits the sun provides accurate distance measurements to stars and nearest galaxies.
- Detects planets orbiting stars, providing planet mass and orbital parameters.
- Detects mysterious Massive Compact Halo Objects (MACHOs) which are a possible explanation for intergalactic dark matter, providing distance & mass from gravitational lensing measurements.
- Measures transverse velocities of stars locally and in nearest galaxies.
- Complements line-of-sight (Doppler) velocity measurements.

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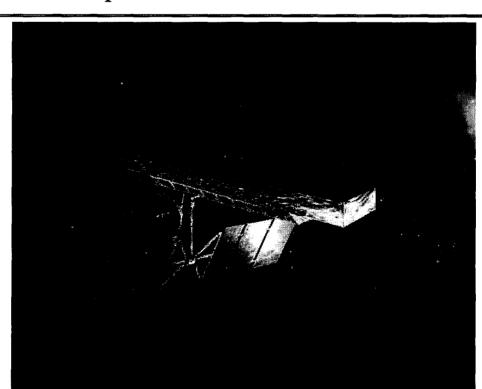


Artist conception



Space Interferometry

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SIM specs

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Space Interferometry

Space

• Four stellar interferometers (two are for bright local "guide" stars, two for dimmer "science" objects.)

- ~10 meter baselines
- Angular accuracy: 5 pico-radians
- Interferometers measure starlight wavefronts to 50 picometer accuracy (because 5 pico-radians = 50 pm / 10 m).
- This implies that relative locations of interferometer optics must be known to better 50 picometers.
- Metrology in SIM is expected to measure distance between optics to ~10 pm **relative** accuracy.
- Metrology expected to measure same distance to ~10 micron absolute accuracy.

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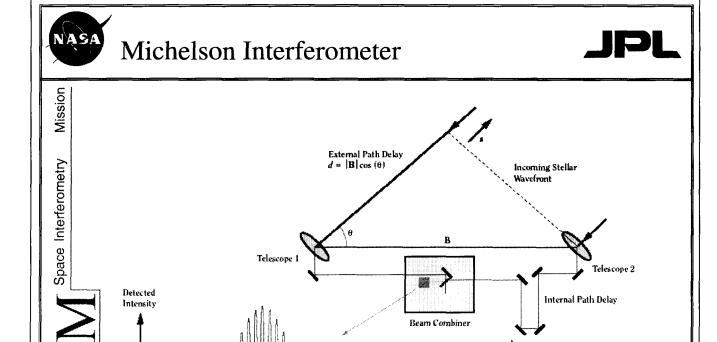
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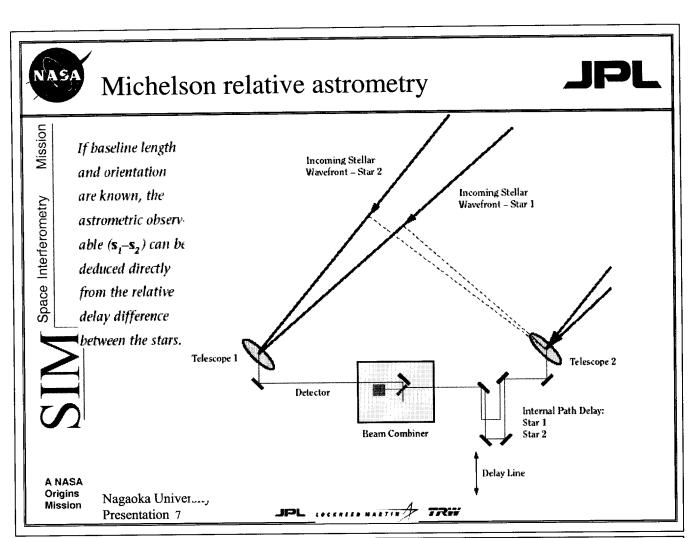
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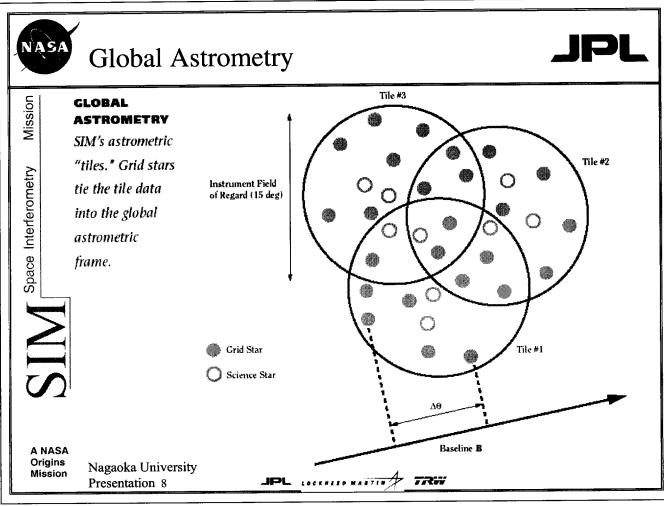
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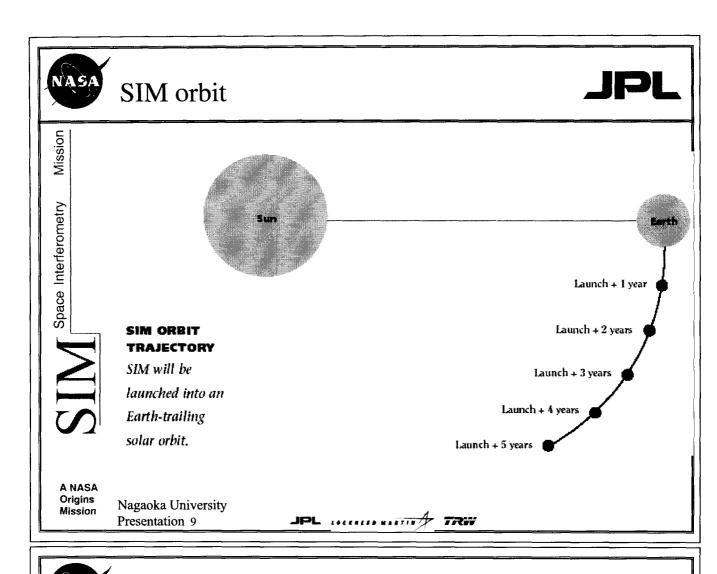


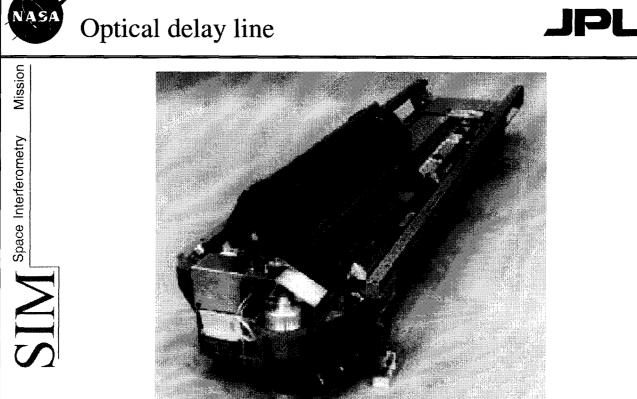
External Delay - Internal Delay

Delay Line







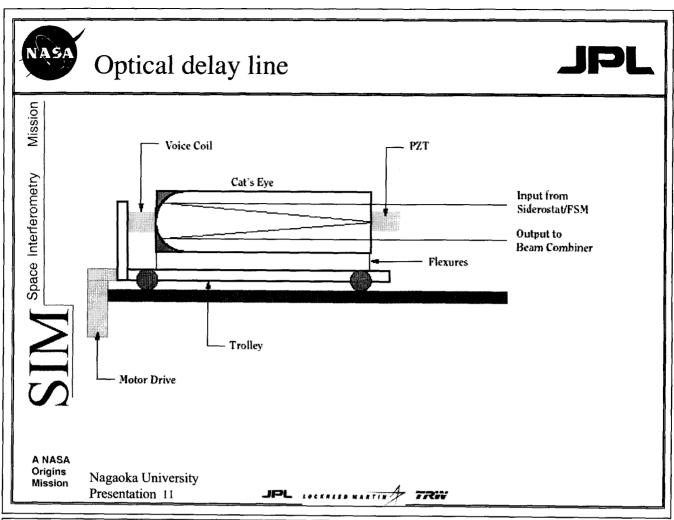


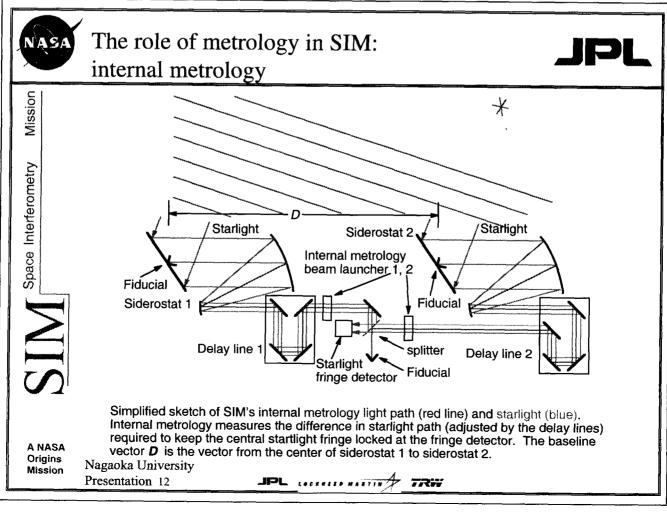
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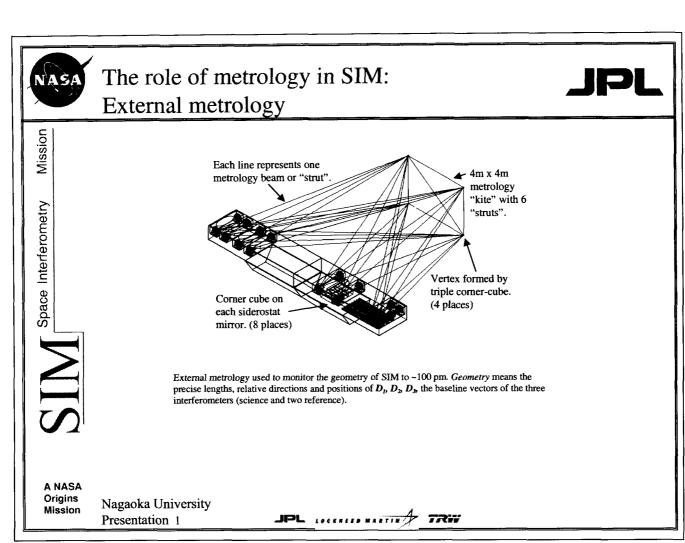
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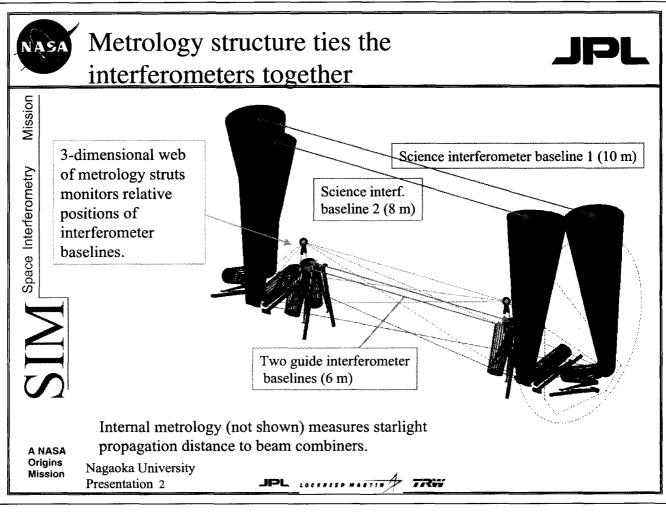
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SIM metrology requirements



Vission

Space Interferometry

SIM

	Internal metrology requirement	External metrology requirement	
Number of gauges	8	42 (kite: 6, roll estimation: 4, siderostats: 32)	
Number of gauges for mission success (assuming dispersed failures)	6 (two siderostats are spares)	24 (Kite: 5, rell estimation: 1, siderostat fiducials: 24)	
Distance between fiducials	20 meters	Varies: shortest are 4 meters, longest are 12 meters.	
Motion; ranges of distances	2.6 meters while changing stars; 10 microns while observing	10 microns	
Velocity	2 cm/s while changing stars, 1 micron/sec while observing	<10 microns/sec ?	
Accuracy (absolute)	Solved for with astrometric data	3 microns rms	
Accuracy (relative)	15 pm rms (1 hour time scale); 8 pm rms (5 minute s)		
Temperature coefficient	2 pm/mK (soak); 50 pm/mK (sensitivity to gradients)		

SIM metrology requirements, subject to change as SIM's design evolves.

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Current metrology performance

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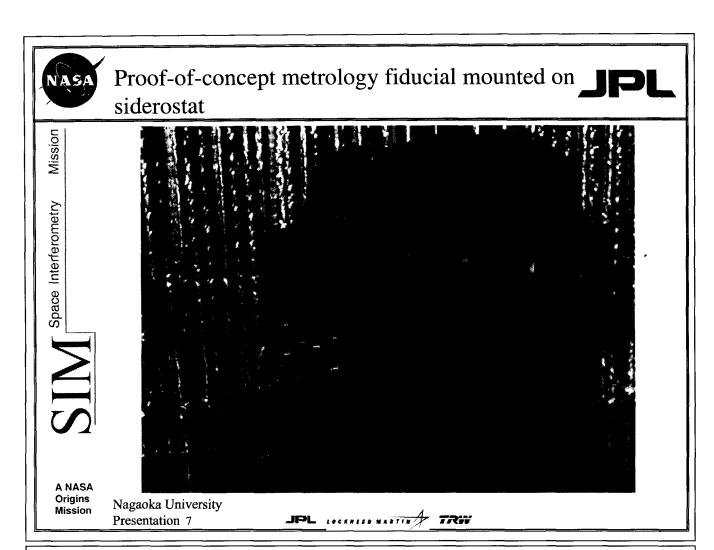
Wavelength	1.3 microns
Distance between fiducials	2.5 meters
Beam diameter	5 mm
Accuracy (absolute)	~5 microns
Accuracy (relative)	~30 picometers
Temperature coefficient	~8 nm/K

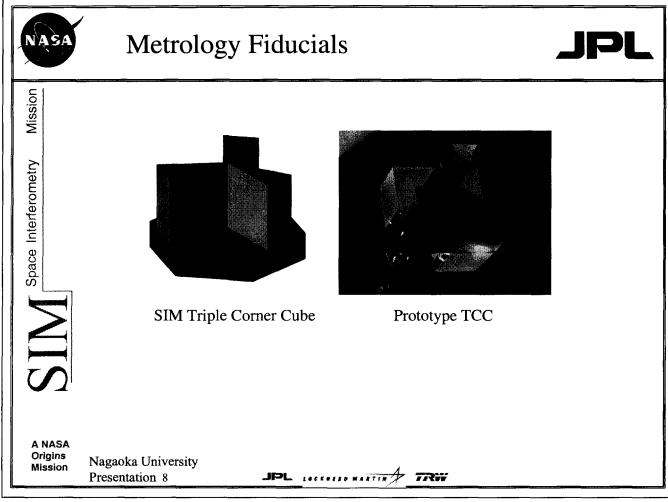
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Metrology system block diagram



erometry Mission

r Space Interferometry

Fiber-optic distribution to other gauges RF1 Beam launcher analog Phase-Frequency shifter 1 front-end & laser. meter zeromod-1.3 µm Frequency ulator crossing Comdetector corner puter

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Digital phasemeter

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Space Interferometry I

•VME based

•6 gauges per board

•(This setup can handle 18 gauges)



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TRW



Digital phasemeter perfomance



Mission

Space Interferometry

SIM

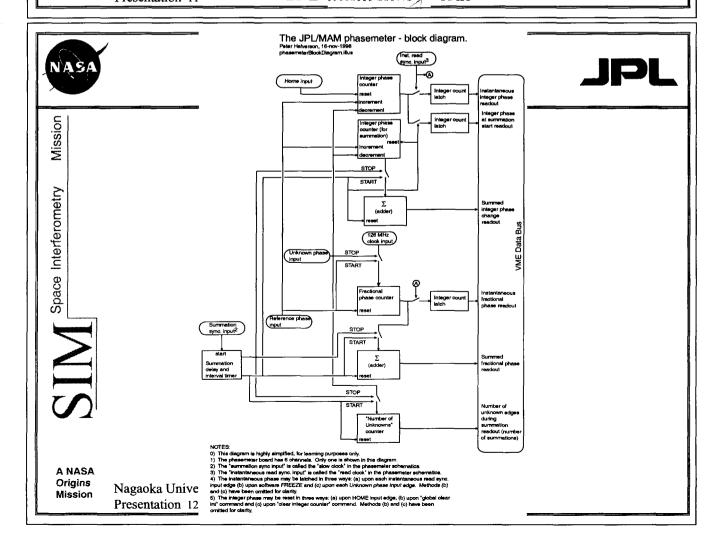
Number of channels (gauges)	6
Maximum clock frequency	128 MHz
Stability	10 ⁻⁵ cycles (6.5 pm) for ambient temperature held to 0.1 C
Range	2 ³² =4.3x10 ⁹ cycles. (2795 meters)
Heterodyne frequency range	1954 Hz to 1.33 MHz
Phase resolution (no averaging)	1.6x10 ⁻⁵ cycles (10 pm) at 2 kHz to 0.01 cycles (650 pm) at 1.3 MHz heterodyne frequency. (Improves with averaging)
Velocity range at maximum heterodyne frequency	+/- 0.88x10 ⁶ cycles per second (0.58 meters/second)
Temperature sensitivity	<500 picoseconds/C (32 pm/C)

Specifications for the JPL phasemeter. Specifications in picometers assume a 100 kHz heterodyne frequency and 1.3 micron wavelength.

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JPL TRW





Upgrade for absolute metrology



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Clock input, A/B (c=fiber-optic 1 kHz TTL typ. toggle coupler) intensity laser A modulator B (master laser offset laser locking output laser B intensity (slave) modulator A

Laser source upgrade for absolute metrology. Light from lasers A and B are held 15 GHz apart by the laser offset locking electronics. A clock signal (in practice, the phasemeter readout clock) toggles intensity modulators A and B. The resulting 500 Hz rate, 15 GHz amplitude FM is fed to the metrology gauge for absolute calibration, as described in the text.

- •Synthetic wavelength is 20 cm.
- •Know absolute distance modulo 10 cm
- •Current accuracy: ~5 microns

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SIM external metrology requires knowledge of absolute distances to 3



Absolute Metrology



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μm
For Kite, the requirement is 10 μm

CC

Metrology Gauge

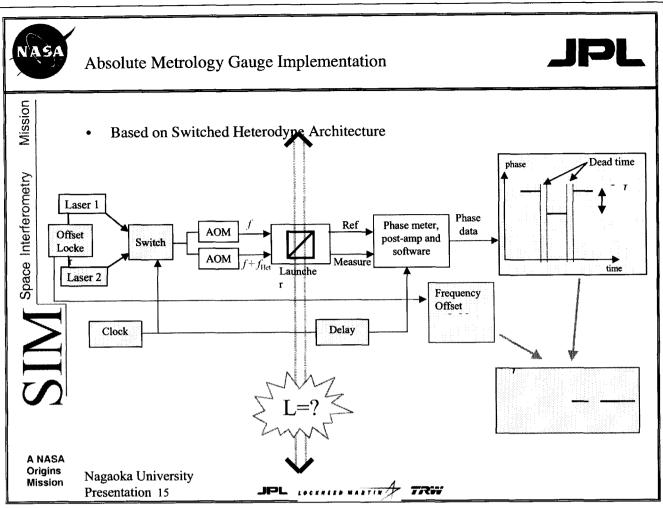
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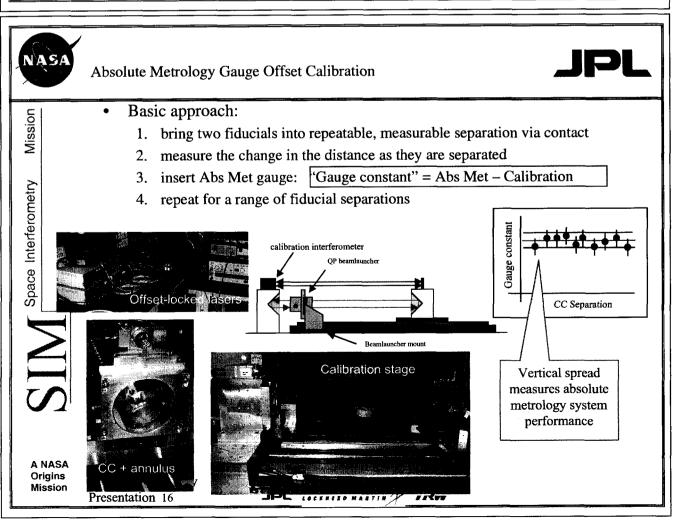
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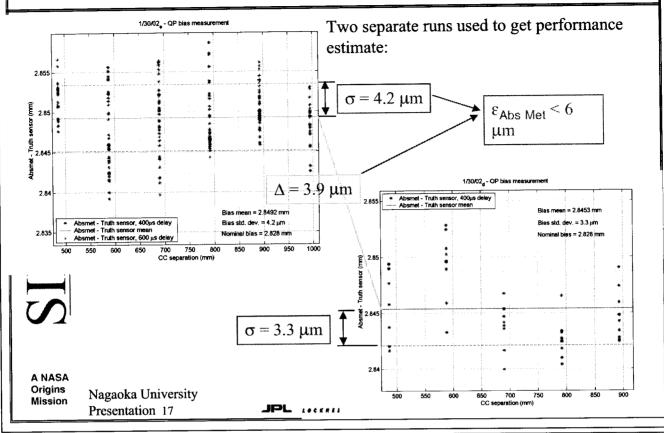






Absolute Metrology Performance Data

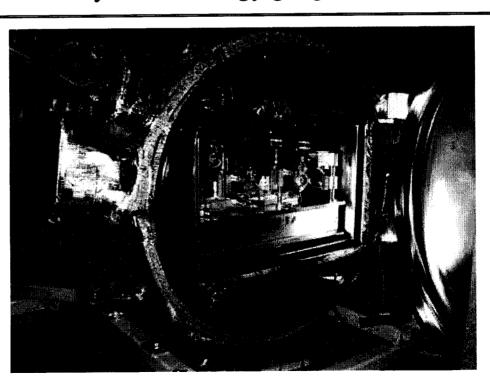




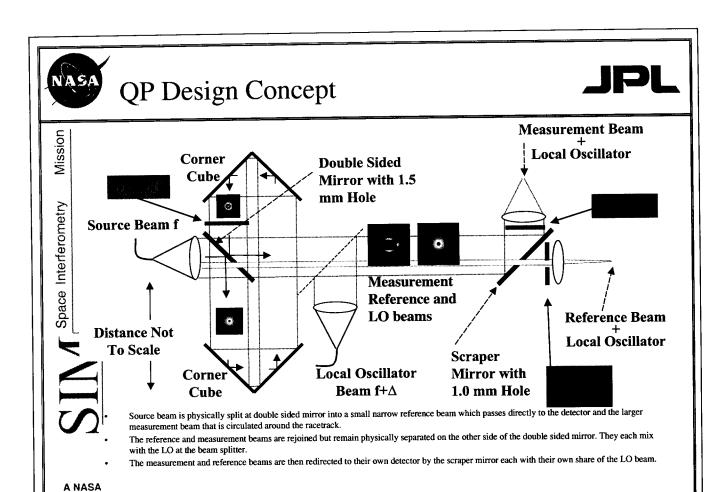


Test facility for metrology gauges

Space Interferometry



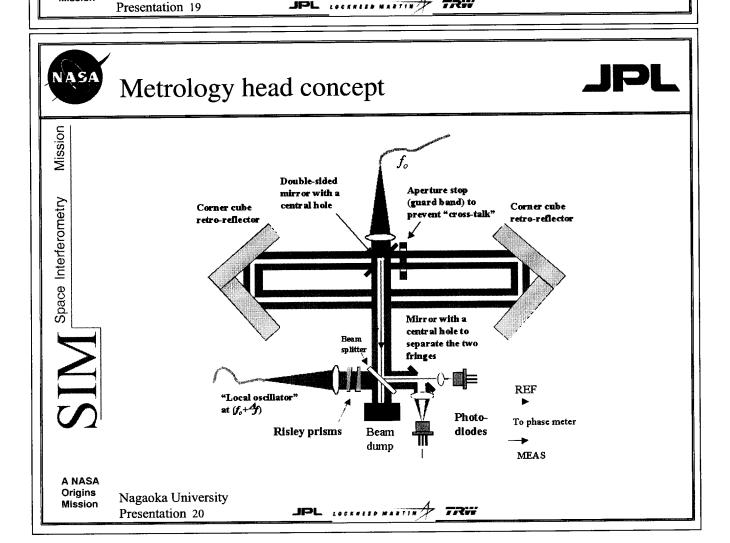
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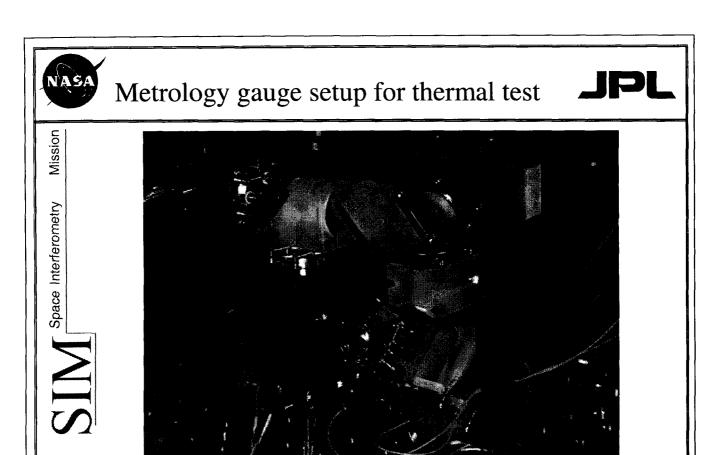


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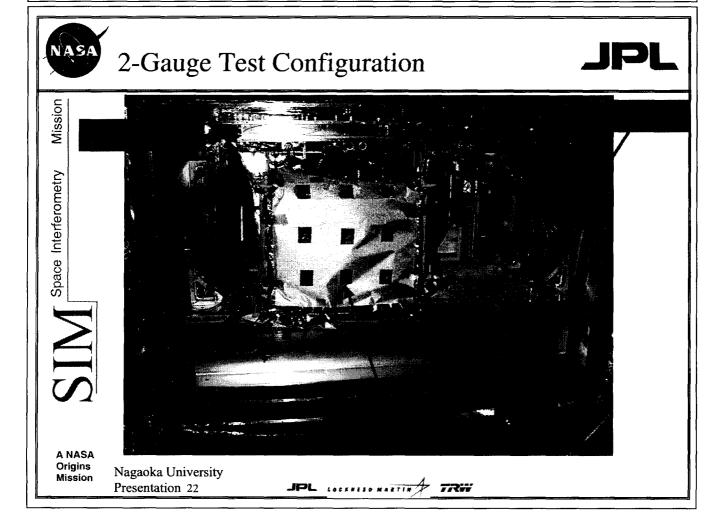




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Metrology gauge test facility block diagram



Mission Space Interferometry

Ramp generator Ref. photodiode Local Oscillator **∕** to ⊥ light Metrology AOM 1 Laser 1.3 µ freq. shift Meas. photodiode Ref. photodiode AOM 2 . Metrology Head B freq. shift Meas, photodiode D E B

Block diagram of laser heterodyne interferometer which measures changes in L, the distance between retroreflectors CC1 and CC2. An optional second gauge (shown in gray) can measure the same distance, allowing useful gauge comparisons. The letters A..E indicate regions where cyclic error originates. For cyclic error detection, the piezoelectric (PZT) actuator moves CC1 with a voltage ramp that has been precompensated for piezo hysteresis, to achieve near-constant velocity.

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Cyclic error: a periodic non-linearity

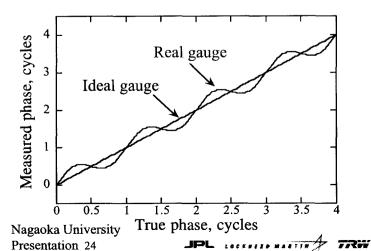


Mission

Space Interferometry

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- Imperfect split of Measurement beam away from reference beam causes constant leakage of M light into wrong path.
- At recombination: M beam + leakage M causes periodic phase advance/retardation ----> Cyclic Error
- To keep cyclic error below 10 pm, must have
 - Optical leakage < 80 dB (low optical cross-talk)
 - Electronic cross-talk < 80 dB
 - Or, if we're lucky, use some "tricks".



phase Constant leakage $(2\pi \text{ of phase for every }\lambda)$

Phasor Diagram

Round trip

of OPD change)



The Role of Kite

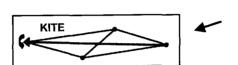
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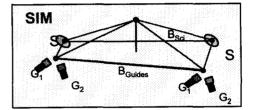
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Space Interferometry

The role of Kite is to verify SIM external metrology performance

- SIM external metrology tracks baseline changes as the fiducials move
- Testing up to now has been 1D (2-gauge)
- The Kite 2D truss will show it can track similar changes to the level required by the SIM performance model (Currently PM36a).





Ideally, Kite performance should be limited by the gauge performance, where the gauge performance is derived from the SIM error budget.

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Kite Approach and Architecture

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TCC

QΡ

issio

Build a **redundant** metrology truss:

- 4 fiducials (2 corner cubes + 2 triple corner cubes)
- 6 metrology gauges connecting the 4 vertices
- All in a plane (to required level)

Interferometry

Space

Compare the readings from one gauge with prediction using the other 5 as a CC is articulated by various amounts of tip and tilt or translation

Account for CC imperfections using CC calibration and model

Take the difference of the residual before vs after

Show the rms error is below requirement for the various

- 0.5 deg articulation (NA) at 50 pm rms
- 7.5 deg articulation (WA) at 300 pm rms
- simulated PSS thermal deformation (1um, 10 um)

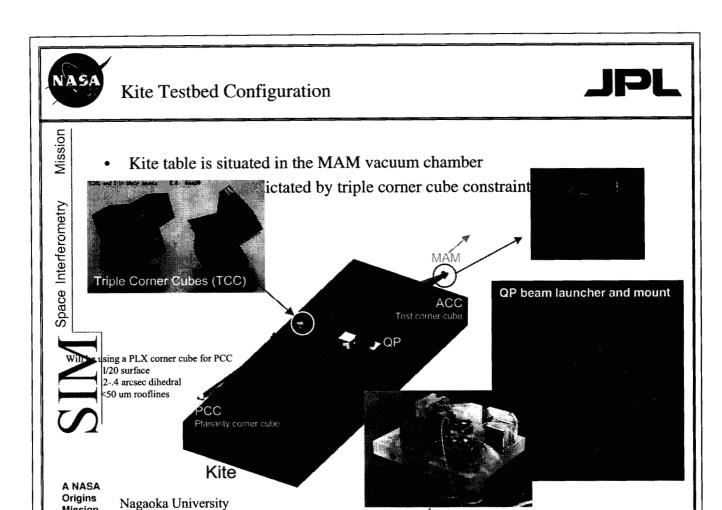
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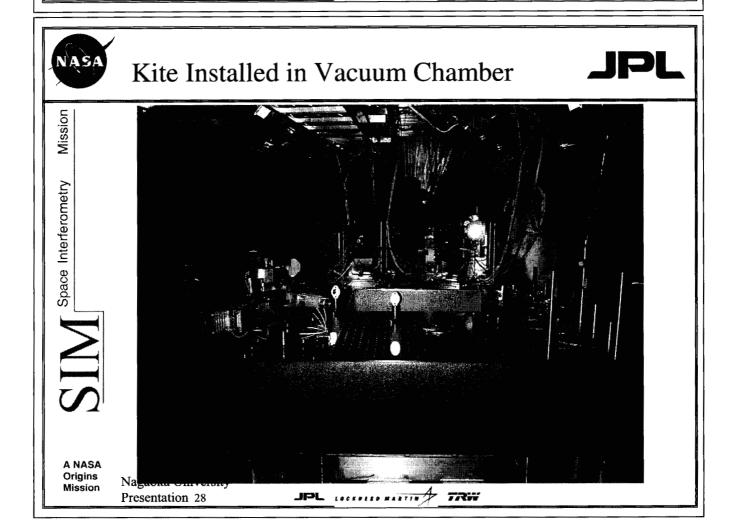




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SIM evolves...

Mission

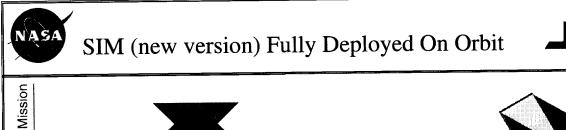
Space Interferometry

New configuration uses fewer metrology measurements

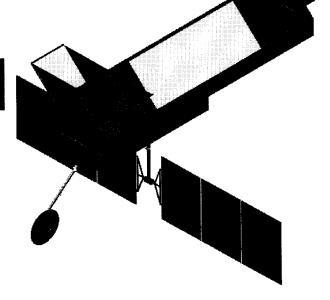
Is more compact: fits into Space Shuttle or Expendable Launch Vehicle

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Space Interferometry



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